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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/720,282	ISHII ET AL.	
Examiner	Art Unit	
William H. Mayo III	2831	

SEARCHED			
Class	Subclass	Date	Examiner
Updated	Search	2/28/2006	WHM
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INTERFERENCE SEARCHED			
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US PG	PUBS	2/28/2006	WHM
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